

Notice of References Cited

Application/Control No.

10/773,629

Applicant(s)/Patent Under
Reexamination
KRISHNAN ET AL.

Examiner

JOHN J. LEE

Art Unit

2618

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,697,073	12-1997	Daniel et al.	455/126
*	B	US-2002/0196766	12-2002	Hwang et al.	370/342
*	C	US-2003/0166407	09-2003	Qian et al.	455/522
*	D	US-2006/0046767	03-2006	Hunzinger, Jason F.	455/522
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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